LeCroy

WaveRunner® 6 Zi Series



THE ULTIMATE DEBUG MACHINE



Superior Validation, Debug, Analysis

The WaveRunner® 6 Zi defines superiority in a test instrument with a powerful feature set including a wide range of application packages, advanced triggering to isolate events, a user interface developed for quick and easy navigation, a wide range of probing options, and lightning-fast performance.

Most Comprehensive Serial Data Analysis

WaveRunner 6 Zi offers the most tools for serial data analysis. With over 17 trigger, decode, and compliance solutions, WaveRunner 6 Zi can address problems with unique, powerful views and automated tools. The unique measurement toolset, ProtoSync™, combines the oscilloscope view with a simultaneous view of data link layer decodes on the same instrument.

Excellent Signal Fidelity

The WaveRunner 6 Zi oscilloscope family features a pristine signal path that offers unmatched signal fidelity with low noise. The WaveRunner HRO offers a 12-bit ADC, resulting in up to 55 dB Signal-to-Noise Ratio (SNR). This performance is augmented by a huge offset and timebase delay adjustment to allow easy signal and amplifier performance assessment and zooming on vertical and horizontal signal characteristics.



Unbelievable Performance

The WaveRunner 6 Zi oscilloscope is the most versatile scope in the 400 MHz to 4 GHz class. The performance offered is unmatched, offering deep memory, 40 GS/s sample rate, low noise and fast operation to help get the job done quickly and accurately.

The WaveRunner HRO 6Zi defines the best in class noise performance with a 12 bit ADC to provide the best resolution. The HRO 6Zi also features deep memory options up to 256 Mpts/Ch.

The toolset provides every necessity for an engineer to validate a design, debug errors at board bring up, and offer powerful analysis to characterize an embedded system. The WaveRunner 6 Zi is the ultimate debug machine.



A New Way to Navigate and View

The WavePilot control area provides convenient control of Cursors, Decode, WaveScan,™ History, LabNotebook,™ and Spectrum by their respective function buttons on the front panel.

The SuperKnob is a joystick-like knob in the center of the WavePilot control area used to easily navigate through tables, zoom and position waveforms, and quickly document and annotate your setups.

Simply slide the button on the left side of the display and rotate upwards 90°. The display will automatically change from landscape to portrait mode. The display will also pivot upwards and downwards to optimize viewing angle.







COMPLETE DEBUG SOLUTION FROM 400 MHz-4 GHz

WaveRunner 6 Zi combines the power of a fully featured multi-purpose oscilloscope, a dedicated logic analyzer for mixed signal design, and a protocol analyzer for serial data debug.

- Industry leading performance—
 400 MHz—4 GHz, 40 GS/s,
 256 Mpts of analysis memory
- 12.1" Widescreen (16 x 9) high resolution WXGA color touch screen display
- 3. 90° rotating and tilting display for optimal viewing of signals
- 4. Small footprint, only 8.1" deep
- Easy connectivity with two convenient USB ports on the front, two on the side
- **6.** USBTMC (Test and Measurement Class) port simplifies programming
- X-Stream[™] II streaming architecture 10–100 times faster analysis and better responsiveness than other oscilloscopes

Accessory pouch option available.





- Deepest toolbox with more measurement, more math, more power
- Largest selection of serial triggers and decoders—more than 17—available to provide a total system view
- Serial trigger captures signals up to 3 Gb/s
- 11. WavePilot consolidates important oscilloscope debug features in one place. LEDs illuminate to indicate navigation options and active oscilloscope features
- 12. The SuperKnob provides joystick control to easily navigation to key debug and documentation features
- **13.** LBUS provides easy connection to the optional mixed signal feature, providing up to 36 digital channels
- 14. Wide array of probes and accessories to accommodate any probing challenge



12-BIT HIGH RESOLUTION OSCILLOSCOPE

Features

- 12-bit ADC resolution
- 400 MHz and 600 MHz models
- 256 Mpts/Ch
- ±0.5% F.S. DC gain accuracy
- 55 dB SNR
- 1 mV vertical Sensitivity
 @ full bandwidth
- Up to ±400 V offset capability
- 20 MHz, 100 MHz, 200 MHz, 350 MHz filters for additional noise filtering

WaveRunner HRO 6 Zi

The WaveRunner HRO features an industry leading 12-bit Analog to Digital Convertor (ADC), deep memory of 256 Mpts/Ch, and superior DC accuracy specifications. These features are in addition to the extensive analysis features of the WaveRunner 6 Zi. Engineers no longer have to compromise high resolution for deep analysis.

ADC Resolution	Number of Steps	Dynamic Range
8	256	48 dB
12	4096	72 dB

Resolution refers to the number of levels available.

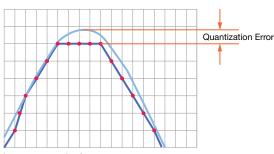
Number of levels = 2 bits of resolution

Designed for the medical, automotive, power, and electromechanical markets, the WaveRunner HRO has higher resolution and measurement precision than 8-bit alternatives. Traditional oscilloscopes use 8-bit ADCs to digitize the data, which is not enough for many applications that require viewing signals with both a large and small voltage component. The reduced noise and improved resolution of the 12-bit ADC architecture provides finer measurement accuracy and better waveform clarity. This can be seen with the superb 55 dB signal to noise ratio (SNR) and ±0.5% DC vertical gain accuracy, which is up to four times better than typical 8-bit oscilloscopes.

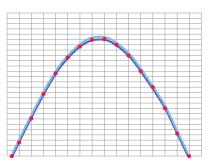
	Smallest Voltage Step			
Full Scale	8-bits	12-bits		
80 V	312.5 mV	19.5 mV		
40 V	156.2 mV	9.76 mV		
20 V	78.1 mV	4.88 mV		
8 V	31.3 mV	1.95 mV		
4 V	15.6 mV	976 μV		
1.6 V	6.3 mV	390 μV		
800 mV	3.1 mV	195 μV		
400 mV	1.56 mV	97.6 μV		
160 mV	625 μV	39 μV		
80 mV	313 μV	19.5 μV		
40 mV	156 μV	9.76 μV		
16 mV	62.5 μV	3.9 µV		
8 mV	31.2 μV	1.95 μV		

16 Times More Resolution

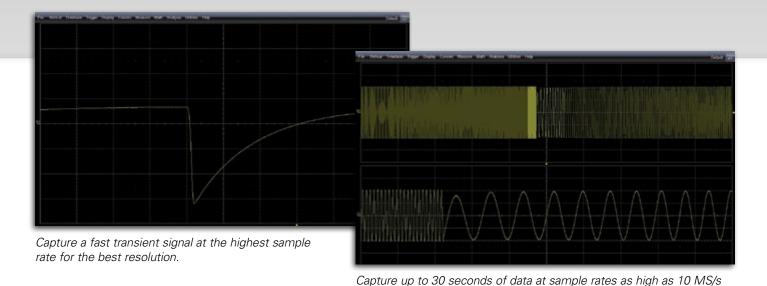
12-bits of vertical resolution provides sixteen times more resolution than 8-bits. The 4096 discrete levels reduce the quantization error and improve the voltage accuracy. The difference in accuracy is shown below. The lower resolution waveform shows a higher level of quantization error, while the higher resolution waveform shows a more accurate representation of the actual waveform.



Lower resolution



Higher resolution

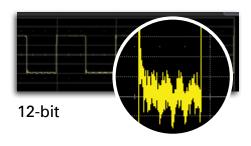


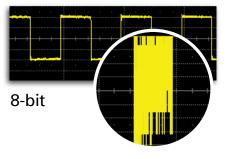
256 Mpts/Ch Deep Memory

High resolution applications typically require a very long acquisition, capturing up to 30 seconds of data to detect very slow or gradual changes. The 2 GS/s, 256 Mpts/Ch architecture provides the ability to capture a fast transient or a long acquisition.

12-bit High Resolution

A common application for high resolution products is the ability to view a small amplitude signal within a larger voltage signal. The 4096 discrete amplitude levels and 55 dB SNR of the WaveRunner HRO 6 Zi can detect much smaller voltage signals with more clarity than an 8-bit oscilloscope.





WaveRunner HRO 6 Zi Analysis Tools

for trending and searching for events.

Conventional high resolution products have very limited analysis tools, such as FFT, math, measurements, and triggers. The WaveRunner HRO 6 Zi offers a full suite of analysis tools to address the most challenging test needs.

Spectrum Analysis

16 Multiple Grids

Pass Fail Testing

Power Analysis

SDA II Serial Data

Analysis

JitKit Clock Jitter

Analysis

History Mode

Measurement Trigger

All Instance

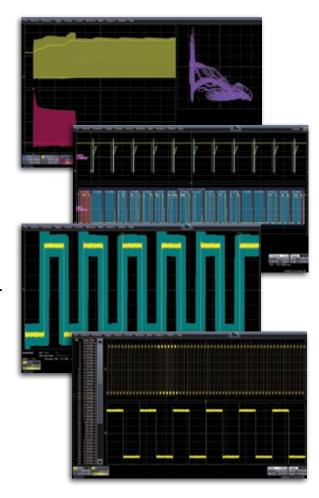
Measurements

WaveScan

Full Customization

with XDEV

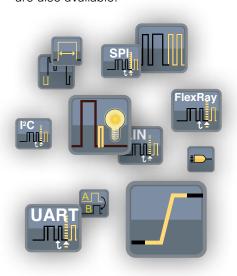
TriggerScan – Rare Event Capture

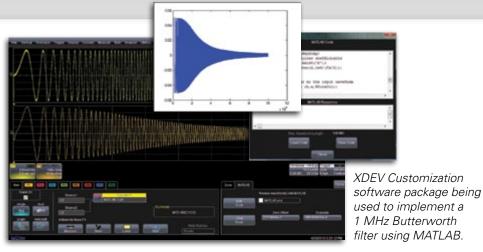


DEEP INSIGHT TO CLARIFY COMPLEX SIGNALS

More Trigger Capability Isolates More Problems More Quickly

A powerful combination of high bandwidth edge and 10 different SMART triggers, four stage cascade triggering, measurement trigger, and triggerscan are all standard and allow you to isolate the problem quickly and begin focus on the cause. The measurement trigger offers a powerful option to qualify a trigger event based on a qualified measurement with great resolution. A high-speed serial trigger enables triggering on up to 3 Gb/s serial patterns of up to 80-bits in length. A full range of serial triggers (I2C, SPI, UART, RS-232, Audio (I2S, LJ, RJ, TDM), CAN, LIN, FlexRay, MIL-STD-1553, SATA, PCle, 8b/10b, USB2 and many others) are also available.





Customized Tools

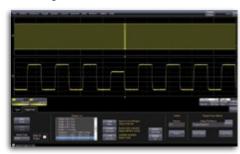
Only LeCroy completely integrates third party programs into the oscilloscope's processing stream by allowing you to create and deploy a new measurement or math algorithm directly into the oscilloscope environment and display the result on the oscilloscope in real-time! Use C/C++, MATLAB,® Excel, JScript (JAVA), and Visual Basic to create your own customized math functions, measurement parameters, or other control algorithms.

History Mode

History mode lets you scroll back in time to isolate those anomalies, measure them with parameters or cursors, and quickly find the source of the problem. History mode is always buffering waveforms, so no user action is required to save traces, only to invoke the viewer.

TriggerScan[™]

TriggerScan uses high-speed hardware triggering capability with persistence displays to capture only the signals of interest and provide answers up to 100 times faster than other methods. Traditional fast display update modes work best on frequent events occurring on slow edge rates while TriggerScan excels in finding infrequent events on fast edge rates.



A 1 in a billion rare event seems fast but is only 5 seconds of circuit operation on a 200 MHz clock. TriggerScan finds the rare event in 4 minutes while an oscilloscope with 400,000 waveforms/second capture rate misses 99.8% of the signals and could spend nearly 42 minutes to find the error.

X-Stream II Architecture

Optimized for Fast Throughput

X-Stream II architecture enables high throughput of data. X-Stream II uses variable waveform segment lengths to enable all processing intensive calculations to take place in fast CPU cache memory.

Learn More

http://www.lecroy.com/dl/5213

Optimized for Long Memory

X-Stream II has no analysis memory length restrictions, regardless of analysis type, since the variable waveform segment length can always be limited to a size that can fit in CPU cache memory.

Optimized for Responsiveness

By dynamically allocating buffers to maximize memory availability, the WaveRunner 6 Zi Series embodies the fastest front panel responsiveness.

Learn More

http://www.lecroy.com/dl/5214

DISPLAY OPTIMIZED FOR ANALYSIS

Graphical Track, Trend, and Histogram Views

Track plots measurement values on the Y-axis and time on the X-axis to display a measurement change time-correlated to the original channel acquisition—perfect for intuitive understanding of behaviors in frequency modulated (FM) or pulse width modulated (PWM) circuits and jitter measurements, including modulation or spikes. Histograms provide a visual distribution representation of a large sample of measurements, allowing faster insight. Trends are ideal for plotting slow changes in measurement values.

Rotating Display

The 12.1" high resolution WXGA wide screen is designed to provide the best view of any signal type on the display.

The widescreen is ideal for a variety of signals where long records are required and zooming or scrolling results in a large block of data.

View 36 digital traces with the

MS500-36 in portrait mode to

Rotate the screen 90° degrees to optimize the display for viewing digital signals, jitter tracks, eye diagrams, and frequency plots. The screen image will adjust automatically when rotated.

Tilt the display up or down in either orientation to minimize reflections or glare.



A TOTAL SOLUTION FOR SERIAL DATA

The WaveRunner 6 Zi features the most complete serial data solutions. Solving serial data problems requires intimate knowledge of the protocol to get started. With the WaveRunner 6 Zi, the oscilloscope is the expert. Simply connect your probes or cables and the scope can provide correct level of detail needed to view, debug, and analyze the serial data signals.

Solutions address the Embedded, Military and Avionics, Handset/Mobile/ Cellular, and Storage/ Peripherals/Interconnects, with a combination of decode, trigger, measure/ graph, ProtoSync, and compliance tools.

Whether the protocol under test is a new emerging standard requiring jitter end eye diagram testing, a mature standard requiring compliance testing, or an embedded standard requiring protocol and measurement and timing analysis, WaveRunner 6 Zi has it all.



View

Decode

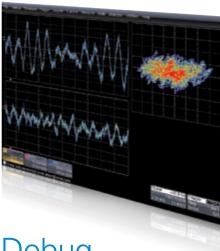
Viewing the protocol layer has never been easier with the intuitive color overlay. Advanced software algorithms understand the selected protocol and deconstruct the waveform into protocol information, then overlay the decoded data on the waveform.

Table

The table feature turns your oscilloscope into a protocol analyzer. Custom configure the Table to display only the information you want, and export table data to an excel file. Touch a message in the table and automatically zoom for detail. This feature is standard with decode options.

Search

Serial data messages can be quickly located by searching on Address, Data, and other attributes specific to a particular protocol. This feature is standard with decode options.



Debug

Measure

Timing and bus measurements allow quick and easy characterization of a serial data system. The PROTObus MAG toolkit is the basic building block upon which many other serial trigger and decoder options can be added.

Graph

Extract data from the serial protocol message stream and use the track functions to graphically plot that data on the display. The digital data is used to create an analog waveform that can then be compared to other electrical signals.

Learn More http://lcry.us/oHoltC

True Hardware Protocol Trigger

An 80-bit serial trigger for serial data signals up to 3 Gb/s (including SATA, PCIe, 8b/10b and USB2.0) and a conditional trigger (I²C, SPI, UART, CAN, LIN, FlexRay,™ I²S, Mil-STD-1553) can completely isolate specific message events.



Eye Diagrams

Create eye diagrams utilizing the full memory for maximum statistical significance. Unique eye diagram features such as IsoBER and eye violation locator provide powerful insight into physical layer analysis.

Jitter

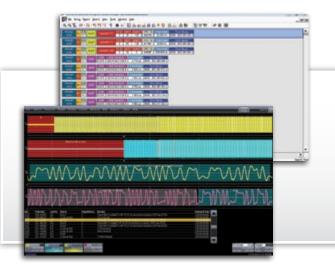
Serial Data **Protocol Supp**

> Embedded Military & Avionics Automotive

Storage / Peripherals Interconnects

oort	Decode	Trigaer	Measura	Proto S	QuailPHV
I ² C	•	•	•		
SPI	•	•	•		
I ² S	•	•	•		
UART, RS-232	•	•	•		
CAN	•	•	•		
LIN	•	•	•		
FlexRay	•	•	•		
ARINC 429	•		•		
MIL-STD-1553	•	•	•		
DigRF 3G	•		•		
MIPI D-PHY /CSI-2/DSI	•				•
DigRF v4	•		•		
8b/10b	•	•			
Fibre Channel	•			•	
SATA (1.5 & 3 Gb/s)	•	•		•	•
SAS (1.5 & 3 Gb/s)	•			•	
PCIe (Gen1)	•	•		•	•
USB 2.0	•	•		•	•
LPDDR2					•
DDR2					•
Ethernet					•

The integrated clock and jitter analysis tools use advanced jitter decomposition methodologies and tools to provide more information about root cause. TJ analysis, RjBUj analysis and DDj analysis is made simple with the deepest toolset dedicated to



ProtoSync

providing the highest level of insight

into your serial data signals.

Automated compliance and testing is simplified with the

QPHY software option. QPHY

connection diagrams, and test

reports to greatly simplify the

compliance process.

http://lecroy.com/serialdata

Learn More

features automated scripts,

Learn More

http://lcry.us/n10mTV

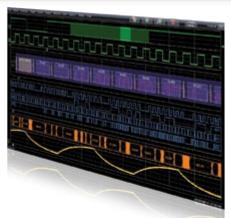
Compliance

ProtoSync combines the oscilloscope view with a simultaneous view of data link layer decodes on the same instrument. This combination makes ProtoSync very effective in debugging PCI Express negotiation rates.

Compatible with PCI Express, USB 2, SAS, SATA, and Fibre Channel.

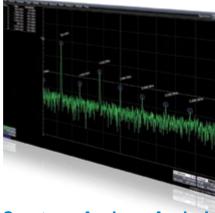
APPLICATION SPECIFIC SOLUTIONS

In addition to the general purpose WaveShape
Analysis tools, application specific solutions are available for Serial Data
Compliance, Embedded
Design, Digital Design, and
Automotive. These options extend the LeCroy standard measurement and analysis capabilities and expand your oscilloscope's utility as your needs change.



Digital Filter Software Option (WR6Zi-DFP2)

DFP2 lets you implement Finite or Infinite Impulse Response filters to eliminate undesired spectral components, such as noise, and enhances your ability to examine important signal components. You can choose from a standard set of FIR or IIR filters. You can also design your own filters.

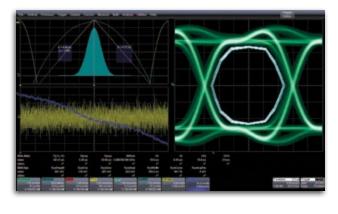


Spectrum Analyzer Analysis Option (WR6Zi-SPECTRUM

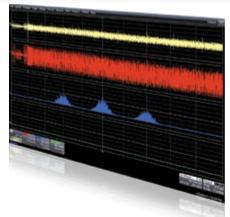
SPECTRUM converts the controls of your oscilloscope to those of a spectrum analyzer. Adjust the frequency span, resolution and center frequency. Apply filtering to your signal and watch the frequency signature change in real time. A unique peak search labels spectral components and presents frequency and level in a table. Touch any line to move to that peak.

SDA II – Advanced Tools to Isolate and Analyze Option (WR6Zi-SDAII)

Unleash the power of serial data analysis for understanding and characterizing your design, proving compliance and understanding why a device or host fails

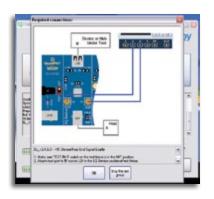


compliance. The X-Stream II architecture provides fast updates and creates eye diagrams 100 times faster than other instruments. Combined with up to 128 Mpts record lengths and more complete jitter decomposition tools, SDA II provides the fastest and most complete understanding of why serial data fails a compliance test. Whether debugging eye pattern or other compliance test failures, the WaveRunner 6 Zi Series rapidly isolates the source of the problem in your design. Advanced jitter decomposition methodologies and tools provide more information about root cause. Tj Analysis, RjBUj Analysis and DDj Analysis is made simple with the deepest toolset dedicated to providing the highest level of insight into your serial data signals.



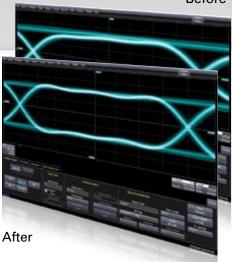
Disk Drive Measurements Software Option (WR6Zi-DDM2)

DDM2 converts your oscilloscope into a Disk drive analysis machine providing 28 custom measurements. Use the PWxx, amplitude, pulse shape, and ACSN parametric measurement toolset to accelerate design and debug.



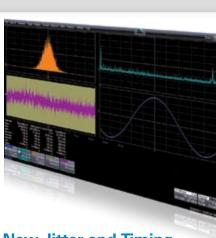
Serial Data Compliance Option

LeCroy's QualiPHY compliance test suite provides the best available solutions to automate, configure and document standardized tests. The QualiPHY compliance test suite provides step-by-step instructions for testing compliance on a wide array of serial data standards. Complete test reporting is also provided.



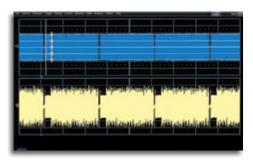
Cable De-Embedding Option (WR6Zi-CBL-DE-EMBED)

Even expensive, high-performance cabling can have an adverse effect on measurements and decrease margin from a design. Cable losses and slow rise times can lead to intersymbol interference causing you to counter these measurement effects. The cable de-embedding feature removes these adverse effects providing more accurate measurements.



New Jitter and Timing Analysis Option (WR6Zi-JITKIT)

JITKIT makes it simple and easy to understand the basic system jitter performance of clock signals and clock-data activities, including period, half period, cycle-cycle, skew, amplitude, differential voltage crossing, slew rate, and a wide variety of other common jitter measurements.



Disk Drive Analyzer Software Option (WR6Zi-DDA)

DDA enables on button access to all the tools needed to accurately debug and analyze disk drive operation.

The DDA user interface and tool set provides specific drive triggers (Sector, Servo gate, Read Gate), and advanced analysis tools (Head filter Equalizer Emulation, Channel Emulation, SAM histograms, and Analog Compare).

PROBES

High-performance probes are an essential tool for accurate signal capture. Consequently LeCroy offers an extensive range of probes to meet virtually every application need. Optimized for use with LeCroy oscilloscopes, these probes set new standards for responsiveness and signal detection.

WaveLink® Differential Probes (4 GHz – 6 GHz) D610/D620, D410/D420 D600A-AT, D300A-AT, D500PT, D610-PT, D620-PT, D410-PT, D420-PT



WaveLink® probes provide industry leading technology for wideband signal connection to test instruments. The first differential probes to employ SiGe technology, they deliver full system bandwidth when used with WaveRunner, WavePro, WaveMaster, DDA, and SDA oscilloscopes up to 6 GHz.

Differential Probes (200 MHz-1.5 GHz) ZD1500, ZD1000, ZD500, ZD200



High bandwidth, excellent common-mode rejection ratio (CMRR) and low noise make these active differential probes ideal for applications such as automotive development (e.g. FlexRay) and failure analysis, as well as wireless and data communication design. The ProBus interface allows sensitivity, offset and common-mode range to be displayed on the oscilloscope screen.

ZS Series High Impedance Active Probes

ZS2500, ZS1500, ZS1000, ZS2500-QUADPAK, ZS1500-QUADPAK, ZS1000-QUADPAK



The ZS Series probes provide high impedance and an extensive set of probe tips and ground accessories to handle a wide range of probing scenarios. The high 1 $M\Omega$ input resistance and low 0.9 pF input capacitance mean this probe is ideal for all frequencies. The ZS Series probes provide full system bandwidth for all LeCroy oscilloscopes having bandwidths of 1 GHz and lower.

High Voltage Differential Probes ADP305, ADP300, AP031

5

Low cost active differential probes are intended for measuring higher voltages. The differential techniques employed permit measurements to be taken at two points in a circuit without reference to the ground, allowing the oscilloscope to be safely grounded without the use of opto-isolators or isolating transformers.

Current ProbesCP031, CP030, AP015, CP150, CP500, DCS015



LeCroy current probes reach bandwidths of 100 MHz, peak currents of 700 A and sensitivities of 10 mA/div. Use multiple current probes to make measurements on three-phase systems or a single current probe with a voltage probe to make instantaneous power measurements. LeCroy current probes enable the design and testing of switching power supplies, motor drives, electric vehicles, and uninterruptible power supplies.

High Voltage Passive Probes

PPE1.2KV, PPE20KV, PPE2KV, PPE4KV, PPE5KV, PPE6KV



The PPE Series includes five fixed-attenuation probes covering a range from 2 kV to 20 kV, and one switchable probe providing $\div 10/\div 100$ attenuation for voltage inputs up to 1.2 kV. All fixed-attenuation, standard probes automatically rescale compatible LeCroy oscilloscopes for the appropriate attenuation of the probe.

Passive Probes

PP008-1, PP009-1, PP007-WR-1, PP007-WS-1, PP005A, PP006A, PP010-1, PP011-1



LeCroy passive probes automatically scale the oscilloscope waveforms without user input. Passive probes are the ideal tool for low frequency signals since circuit loading at these frequencies is minimized. Passive probes are designed to handle voltages of at least 400 V, some as high as 600 V.

WaveLink Probes

D410/D420 Differential Probes

The D410/D420 probes boast excellent noise performance that is essential for making precise jitter and other signal integrity measurements. The high DC and midband impedance make them ideal for many serial data and memory applications such as PCI Express, FireWire, and DDR. With ±4 volt offset capability and ±3 volt common mode control, the WaveLink probes are designed for multi-purpose applications for single-ended needs (such as DDR memory) and serial data applications (such as HDMI).

D600A-AT/D500PT Browser

WaveLink browser solutions offer adjustable tip widths and varying form factors and a hand held x-y-z positioner for accurate probe placement.



The WaveLink Differential Probe Series is a high bandwidth active differential probes series. These probes are suited for signal integrity measurements in high-speed digital systems.





Five Different Tips for Interconnect Flexibility



A. Solder-In Lead (SI)

The Solder-In interconnect lead features the smallest physical tip size of any high bandwidth differential probe and the highest level of electrical performance.



B. Quick Connect (QC) (D6xx only)

The Quick Connect interconnect lead enables you to quickly move the probe between multiple test points on the test circuit.



C. Square Pin (SP)

Many applications, such as IC characterization boards, use standard 0.025" square pins for interconnect. The Square Pin interconnect lead directly mates with a pair of 0.025" (0.635 mm) square pins that are mounted on standard 0.100" (2.54 mm) centers.



D. Positioner Tip (PT)

The PT positioner tips provides spring loaded leads to allow for easy probing. The adjustable wheel allows for precise probing, allowing a spread up to 0.14".



E. High Temperature (HiTemp) Cables and Solder-In Lead

The 90 cm HiTemp cables and Solder-In lead is ideally suited for testing scenarios there the temperature can fluctuate from -40 °C to +105 °C.

	WaveRunner HRO 64 Zi	WaveRunner HRO 66 Zi	WaveRunner 604Zi	WaveRunner 606Zi	
Vertical System					
Analog Bandwidth @ 50 Ω (-3 dB)	400 MHz	600 MHz	400 MHz (≥ 2 mV/div)	600 MHz (≥ 2 mV/div)	
Analog Bandwidth @ 1 MΩ (-3 dB)	400 MHz (typical)	500 MHz (typical)	400 MHz (typical)	500 MHz (typical)	
Rise Time (10–90%, 50 Ω)	875 ps (typical)	625 ps (typical)	875 ps (typical)	580 ps (typical)	
Rise Time (20–80%, 50 Ω)	650 ps (typical)	435 ps (typical)	650 ps (typical)	435 ps (typical)	
Input Channels	4				
Bandwidth Limiters	20 MHz, 100 MHz, 200 MHz	20 MHz, 100 MHz, 200 MHz, 350 MHz	20 MHz, 200 MHz	20 MHz, 200 MHz	
Input Impedance	50 Ω ±2% or 1 M Ω 17pF,	10 M Ω 9.5 pF with supplie	d Probe		
Input Coupling	1 MΩ: AC, DC, GND; 50 Ω:	DC, GND			
Maximum Input Voltage	50 Ω: 5 V _{rms} ±10 V peak 1 MΩ: 400 V max. (DC + pea	ak AC < 10 kHz)			
Channel-Channel Isolation	> 31	00:1	> 100:1 up	to rated BW	
Vertical Resolution	12-hits: up to 15-hits with 6	enhanced resolution (ERES)	8-hits: up to 11-hits with e	nhanced resolution (ERES)	
Sensitivity	50 Ω : 1 mV/div–1 V/div, fully 1 M Ω : 1 mV/div–10 V/div, fu	variable	o sito, up to 11 sito with o	Tindhood resolution (Enter)	
DC Vertical Gain Accuracy (Gain Component of DC Accuracy)	±(0.5%) F.S, offset at 0 V		±1% F.S. (typical), offset at 0 V; ±1.5% F.S. (test limit) offset at 0 V		
Offset Range	$\begin{array}{c} 50 \ \Omega: \\ \pm 1.6 \ \lor \ @ \ 1 \ \ \text{mV} - 4.95 \ \ \text{mV} \\ \pm 4 \ \lor \ @ \ 5 \ \ \text{mV} - 9.9 \ \ \text{mV} \\ \pm 8 \ \lor \ @ \ 10 \ \ \text{mV} - 19.8 \ \ \text{mV} \\ \pm 10 \ \lor \ @ \ 20 \ \ \text{mV} - 1 \ \ \ \ \\ \begin{array}{c} 1 \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ $		±4 V @ 5 n ±8 V @ 10 n ±10 V @ 2 1 N ±1.6 V @ 1 n ±4 V @ 5 n ±8 V @ 10 n ±16 V @ 20 ±80 V @ 14	mV- 4.95 mV mV-9.9 mV nV-19.8 mV 20 mV-1 V MΩ: mV-4.95 mV nV-9.9 mV nV-19.8 mV mV-140 mV -2 mV-1.4 V	
DC Vertical Offset Accuracy		g + 0.2% F.S. + 0.02% et + 1 mV)		+1% of full scale + 1 mV) limit)	
Horizontal System					
Timebases	Internal timebase common	to 4 input channels; an exter	nal clock may be applied at t	he auxiliary input	
Time/Division Range		s/div; RIS mode: 20 ps/div–10 (roll mode is user selectable	0 ns/div; e at ≥ 100 ms/div and ≤ 5 MS	/s	
Clock Accuracy	≤ 1.5 ppm +(aging of 1.0 pp	m/yr from last calibration)			
Trigger and Interpolator Jitter	≤ 6 ps _{rms} (typical) < 1.0 ps _{rms} (typical, software assisted)	\leq 5.5 ps $_{ms}$ (typical) $<$ 1.0 ps $_{ms}$ (typical, software assisted)	\leq 4.5 ps $_{rms}$ (typical) $<$ 0.1 ps $_{rms}$ (typical, software assisted)	\leq 4 ps _{rms} (typical) < 0.1 ps _{rms} (typical, software assisted)	
Channel-Channel Deskew Range	±9 x time/div. setting, 100 r	ns max., each channel			
External Timebase Reference (Input)	10 MHz ±25 ppm via option	nal LBUS BNC adapter			
External Timebase Reference (Output)	10 MHz 3.5 dBm ±1 dBm, s via optional LBUS BNC adap		ing used by user (internal or	external reference)	
External Clock	DC to 100 MHz; (50 Ω /1 M Ω) Minimum rise time and amp	Ω), Ext. BNC input, olitude requirements apply a	t low frequencies		

	WaveRunner 610Zi	WaveRunner 620Zi	WaveRunner 625Zi	WaveRunner 640Zi
Vertical System				
Analog Bandwidth @ 50 Ω (-3 dB)	1 GHz (≥ 2 mV/div)	2 GHz (≥ 5 mV/div)	2.5 GHz (≥ 5 mV/div)	4 GHz (≥ 5 mV/div)
Analog Bandwidth @ 1 $M\Omega$ (-3 dB)	500 MHz (typical)	500 MHz (typical)	500 MHz (typical)	500 MHz (typical)
Rise Time (10–90%, 50 Ω)	375 ps (typical)	175 ps (typical)	160 ps (typical)	100 ps (typical)
Rise Time (20–80%, 50 Ω)	280 ps (typical)	130 ps (typical)	120 ps (typical)	75 ps (typical)
Input Channels	4			
Bandwidth Limiters	20 MHz, 200 MHz	20 MHz, 200 MHz, 1 GHz	20 MHz, 200 MHz, 1 GHz	20 MHz, 200 MHz, 1 GHz
Input Impedance	50 Ω ±2% or 1 M Ω 17pF, 1	0 M Ω 9.5 pF with supplied F	Probe	
Input Coupling	1 M Ω : AC, DC, GND; 50 Ω : [DC, GND		
Maximum Input Voltage	50 Ω : 5 V _{rms} ±10 V peak 1 M Ω : 400 V max. (DC + peak	AC < 10 kHz)		
Channel-Channel Isolation		> 100:1 up to rated BW		> 100:1 up to 2.5 GHz > 30:1 from 2.5 GHz to rated BW
Vertical Resolution	8-bits; up to 11-bits with enh	anced resolution (ERES)		
Sensitivity	50 Ω : 1 mV/div–1 V/div, fully 1 M Ω : 1 mV/div–10 V/div, ful			
DC Vertical Gain Accuracy (Gain Component of DC Accuracy)	±1% F.S. (typical), offset at 0	V; ±1.5% F.S. (test limit), offs	set at 0 V	
Offset Range DC Vertical Offset Accuracy	50 Ω: ±1.6 V @ 1 mV-4.95 mV ±4 V @ 5 mV-9.9 mV ±8 V @ 10 mV-19.8 mV ±10 V @ 20 mV-1 V 1 MΩ: ±1.6 V @ 1 mV-4.95 mV ±4 V @ 5 mV-9.9 mV ±8 V @ 10 mV-19.8 mV ±16 V @ 20 mV-140 mV ±80 V @ 142 mV-1.4 V ±160 V @ 1.42 V-10 V		BWL ±1.6 V @ 1 ±4 V @ 5 ±8 V @ 10 ±10 V @ BWL ±1.4 V @ 5 r ±10 V @ 12 1 ±1.6 V @ 1 ±4 V @ 5 ±8 V @ 10 ±16 V @ 20 ±80 V @ 1 ±160 V @ 21	0 Ω: ≤ 1 GHz mV-4.95 mV mV-9.9 mV mV-19.8 mV 20 mV-1 V > 1 GHz nV-122 mV/div 24 mV-1 V/div MΩ: mV-4.95 mV mV-9.9 mV mV-19.8 mV 0 mV-140 mV 42 mV-1.4 V 1.42 V-10 V

Horizontal System

TIOTIZOTICAL O YOCOTTI						
Timebases	Internal timebase common to 4 input channels; an external clock may be applied at the auxiliary input					
Time/Division Range	Real-Time: 20 ps/div–1000 s/div; RIS mode: 20 ps/div–10 ns/div; Roll mode: up to 1000 s/div (roll mode is user selectable at ≥ 100 ms/div and ≤ 5 MS/s					
Clock Accuracy	≤ 1.5 ppm +(aging of 1.0 ppr	m/yr from last calibration)				
Trigger and Interpolator Jitter	≤ 3.5 ps _{rms} (typical) < 0.1 ps _{rms} (typical, software assisted)	≤ 3 ps _{rms} (typical) < 0.1 ps _{rms} (typical, software assisted)	\leq 2.5 ps $_{ms}$ (typical) $<$ 0.1 ps $_{ms}$ (typical, software assisted)	≤ 2 ps _{rms} (typical) < 0.1 ps _{rms} (typical, software assisted)		
Channel-Channel Deskew Range	±9 x time/div. setting, 100 m	ns max., each channel				
External Timebase Reference (Input)	10 MHz ±25 ppm via optiona	al LBUS BNC adapter				
External Timebase Reference (Output)	10 MHz 3.5 dBm ±1 dBm, synchronized to reference being used by user (internal or external reference) via optional LBUS BNC adaptor					
External Clock	DC to 100 MHz; (50 Ω /1 M Ω Minimum rise time and amp	e), Ext. BNC input, litude requirements apply at l	ow frequencies			

	WaveRunner HRO 64 Zi	WaveRunner HRO 66 Zi	WaveRunner 604Zi	WaveRunner 606Zi
Acquisition System				
Single-Shot Sample Rate/Ch	2 GS/s on 4 Ch		10 GS/s 20 GS/s	
Random Interleaved Sampling (RIS)	100 GS/s, user selectable for repetitive signals (20 ps/div to 10 ns/div)		200 GS/s, user selectable for repetitive sig (20 ps/div to 10 ns/div)	
Maximum Trigger Rate	500,000 waveforms/second (in Sequence Mode, up to 4 channels)		1,000,000 waveforms/second (in Sequence up to 4 channels)	
Intersegment Time	2 μs		1	JS
Max. Acquisition Memory Points/Ch	L-128 Opt XL-256 Op		S-32 Option: 32 M-64 Option: 64N	
Standard Memory (4 Ch / 2 Ch / 1 Ch) (Number of Segments)	64 (30,	M 000)	16M / 32 (5,0	
Memory Options (4 Ch / 2 Ch / 1 Ch) (Number of Segments)	L-128 Option: XL-256 Option:		S-32 Option: 32M / 0 M-64 Option: 64M / 1	
Acquisition Processing				
Averaging	Summed averaging to 1 mill	lion sweeps; continuous ave	raging to 1 million sweeps	
Enhanced Resolution (ERES)	From 12.5- to 15-bit	<u> </u>	From 8.5- to 11-bits	s vertical resolution
Envelope (Extrema)	Envelope, floor, or roof for u	p to 1 million sweeps		
Interpolation	Linear or Sin x/x			
Friggering System				
Modes	Normal, Auto, Single, and S	top		
Sources	Any input channel, Ext, Ext/	10, or line; slope and level u	nique to each source (except	line trigger)
Coupling Mode	DC, AC, HFRej, LFRej			
Pre-trigger Delay	0-100% of memory size (ac	ljustable in 1% increments o	or 100 ns)	
Post-trigger Delay	0-50,000,000,000 divisions	in real time mode, limited at	slower time/div settings or i	n roll mode
Hold-off by Time or Events	From 2 ns up to 20 s or from	n 1 to 99,999,999 events		
Internal Trigger Range	±4.1 div from center (typica	l)		
Trigger Sensitivity with Edge Trigger	2 div @ < 400 MHz	2 div @ < 600 MHz	2 div @ < 400 MHz	2 div @ < 600 MHz
(Ch 1–4)	1.5 div @ < 200 MHz	1.5 div @ < 300 MHz	1.5 div @ < 200 MHz	1.5 div @ < 300 MHz
	0.9 div @ < 10 MHz (DC, AC, and	1 div @ < 200 MHz 0.9 div @ < 10 MHz	0.9 div @ < 10 MHz (DC, AC, and	1 div @ < 200 MHz 0.9 div @ < 10 MHz
	LFRej coupling)	(DC, AC, and	LFRej coupling)	(DC, AC, and
	Li rioj coapiing/	LFRej coupling)	Li riej coapiirig,	LFRej coupling)
External Trigger Sensitivity,	2 div @ <	600 MHz	2 div @	
Edge Trigger)	1.5 div @ <	300 MHz	1.5 div @ <	500 MHz
	1 div @ <	200 MHz	1 div @ <	200 MHz
	0.9 div @		0.9 div @ -	
	(DC, AC, and L	, , , , ,	(DC, AC, and L	, , ,
Max. Trigger Frequency,	400 MHz @ ≥	600 MHz @ ≥ 10 mV/div 1.2 ns	400 MHz @ ≥	600 MHz @ ≥
SMART Trigger	10 mV/div 1.9 ns (minimum triggerable width 1.9 ns)	(minimum triggerable width 1.2 ns)	10 mV/div 1.9 ns (minimum triggerable width 1.9 ns)	10 mV/div 1.2 ns (minimum triggerable width 1.2 ns)
External Trigger Input Range	Ext (±0.4 V); Ext/10 (±4 V)	,	, , , , , , , , , , , , , , , , , , , ,	
Desta Titura				
Basic Triggers				
Edge	Triggers when signal meets			
Window	Triggers when signal exits a		ole thresholds	
TV-Composite Video	Triggers NTSC or PAL with s HDTV (720p, 1080i, 1080p) CUSTOM with selectable Fi Interlacing (1:1, 2:1, 4:1, 8:1	with selectable frame rate (9 elds (1–8), Lines (up to 2000), Frame Rates (25, 30, 50, o	r 60 Hz),

	WaveRunner 610Zi	WaveRunner 620Zi	WaveRunner 625Zi	WaveRunner 640Zi		
Acquisition System						
Single-Shot Sample Rate/Ch	10 GS/s on 4 Ch 20 GS/s on 2 Ch		20 GS/s on 4 Ch 40 GS/s on 2 Ch			
Random Interleaved Sampling (RIS)	200 GS/s, user selectable fo	r repetitive signals (20 ps/di	v to 10 ns/div)			
Maximum Trigger Rate	1,000,000 waveforms/secon	000,000 waveforms/second (in Sequence Mode, up to 4 channels)				
Intersegment Time	1 μs	JS				
Max. Acquisition Memory Points/Ch		-32 Option: 32M / 64M / 64M 4-64 Option: 64M / 128M / 128M				
Standard Memory (4 Ch / 2 Ch / 1 Ch) (Number of Segments)	16M / 32M / 32M (5,000)					
Memory Options (4 Ch / 2 Ch / 1 Ch) (Number of Segments)	S-32 Option: 32M / 64M / 64 M-64 Option: 64M / 128M /					
Acquisition Processing						
Averaging	Summed averaging to 1 mill		raging to 1 million sweeps			
Enhanced Resolution (ERES)	From 8.5- to 11-bits vertical					
Envelope (Extrema)	Envelope, floor, or roof for u	p to 1 million sweeps				
Interpolation	Linear or Sin x/x or cubic (us	ing math tool)				
Triggering System						
Modes	Normal, Auto, Single, and St	юр				
Sources	Any input channel, Ext, Ext/	10, or line; slope and level ur	nique to each source (except	line trigger)		
Coupling Mode	DC, AC, HFRej, LFRej					
Pre-trigger Delay	0-100% of memory size (ad	justable in 1% increments o	or 100 ns)			
Post-trigger Delay	0-50,000,000,000 divisions	in real time mode, limited at	slower time/div settings or i	n roll mode		
Hold-off by Time or Events	From 2 ns up to 20 s or from	n 1 to 99,999,999 events				
Internal Trigger Range	±4.1 div from center (typical)				
Trigger Sensitivity with Edge Trigger (Ch 1–4) ProBus Inputs	2 div @ < 1 GHz 1.5 div @ < 500 MHz 1 div @ < 200 MHz 0.9 div @ < 10 MHz (DC, AC, and LFRej coupling)	2 div @ < 2 GHz 1.5 div @ < 1 GHz 1 div @ < 200 MHz 0.9 div @ < 10 MHz (DC, AC, and LFRej coupling)	2 div @ < 2.5 GHz 1.5 div @ < 1.25 GHz 1 div @ < 200 MHz 0.9 div @ < 10 MHz (DC, AC, and LFRej coupling)	2 div @ < 4 GHz 1.5 div @ < 2 GHz 1 div @ < 200 MHz 0.9 div @ < 10 MHz (DC, AC, and LFRej coupling)		
External Trigger Sensitivity, (Edge Trigger)	2 div @ 1 GHz 1.5 div @ < 500 MHz 1 div @ < 200 MHz 0.9 div @ < 10 MHz (DC, AC, and LFRej coupling	ı)				
Max. Trigger Frequency, SMART Trigger	1.0 GHz @ ≥ 10 mV/div (minimum triggerable width 750 ps)	2.0 GHz @ ≥ 10 mV/div (minimum triggerable width 400 ps)	2.0 GHz @ ≥ 10 mV/div (minimum triggerable width 300 ps)	2.0 GHz @ ≥ 10 mV/div (minimum triggerable width 200 ps)		
External Trigger Input Range	Ext (±0.4 V); Ext/10 (±4 V)	•				
Basic Triggers						
Edge	Triggers when signal meets	slope (positive, negative, or	either) and level condition			
Vindow	Triggers when signal exits a	1 1 , 0 ,	· · · · · · · · · · · · · · · · · · ·			
TV-Composite Video	Triggers NTSC or PAL with s HDTV (720p, 1080i, 1080p)	relectable line and field; with selectable frame rate (5 elds (1–8), Lines (up to 2000	50 or 60 Hz) and Line; or), Frame Rates (25, 30, 50, o	r 60 Hz),		

	WaveRunner HRO 64 Zi HRO 66 Zi	WaveRunner 604 Zi 606 Zi	WaveRunner 610 Zi 620 Zi	WaveRunner 625 Zi 640 Zi
SMART Triggers				
State or Edge Qualified	Triggers on any input source Delay between sources is s		dge occurred on another inpu	ut source.
Qualified First			vent B only if a defined patte off between sources is selec	
Dropout	Triggers if signal drops out f	or longer than selected time	e between 1 ns and 20 s	
Pattern			(4 channels and external trigger can be selected independen	
SMART Triggers with Exclusion	ion Technology			
Glitch	Triggers on positive or negation bandwidth) to 20 s, or on in-	=	lectable as low as 200 ps (de	epending on oscilloscope
Width (Signal or Pattern)	Triggers on positive or nega bandwidth) to 20 s, or on in	•	ectable as low as 200 ps (de	pending on oscilloscope
Interval (Signal or Pattern)	Triggers on intervals selecta	ble between 1 ns and 20 s		
Timeout (State/Edge Qualified)	Triggers on any source if a g Delay between sources is 1		e) has occurred on another s 99 events	source.
Runt	Trigger on positive or negati Select between 1 ns and 20	•	tage limits and two time limi	ts.
Slew Rate	Trigger on edge rates. Selec	t limits for dV, dt, and slope	Salact adda limits between	1 ns and 20 ns
		s by specifying the expected	d behavior and triggering who	
Exclusion Triggering Measurement Trigger Cascade (Sequence) Triggering	Trigger on intermittent fault: Trigger on measurement val	s by specifying the expected	d behavior and triggering who	en that condition is not me
Measurement Trigger	Trigger on intermittent faults Trigger on measurement val ng Arm on "A" event, then Trig "C" event. Or Arm on "A" e	s by specifying the expected lues, Edge, Serial Pattern, B gger on "B" event. Or Arm o event, then Qualify on "B" t	d behavior and triggering who us Pattern, Non-monotonic on "A" event, then Qualify o then "C" event, and Trigger o	en that condition is not me n "B" event, and Trigger o on "D" event
Measurement Trigger Cascade (Sequence) Triggeri	Trigger on intermittent faults Trigger on measurement val ng Arm on "A" event, then Trig "C" event. Or Arm on "A" e	s by specifying the expected lues, Edge, Serial Pattern, B gger on "B" event. Or Arm o event, then Qualify on "B" t	d behavior and triggering who us Pattern, Non-monotonic on "A" event, then Qualify o	en that condition is not me n "B" event, and Trigger o on "D" event
Measurement Trigger Cascade (Sequence) Triggerin Capability Types	Trigger on intermittent faults Trigger on measurement value Arm on "A" event, then Trig "C" event. Or Arm on "A" et a., B, C, or D event: Edge, G Measurement Trigger	s by specifying the expected lues, Edge, Serial Pattern, B gger on "B" event. Or Arm o event, then Qualify on "B" t Blitch, Width, Window, Dropo	d behavior and triggering who us Pattern, Non-monotonic on "A" event, then Qualify o then "C" event, and Trigger o	en that condition is not me n "B" event, and Trigger o on "D" event e, or Pattern (analog),
Measurement Trigger Cascade (Sequence) Triggerin Capability Types Holdoff Reset	Trigger on intermittent faults Trigger on measurement value Arm on "A" event, then Trig "C" event. Or Arm on "A" et al. (A, B, C, or D event: Edge, C) Measurement Trigger Holdoff between A and B, B a	lues, Edge, Serial Pattern, B gger on "B" event. Or Arm of event, then Qualify on "B" t Ellitch, Width, Window, Dropo B and C, C or D, or any is sell and C, C and D, or any comb	us Pattern, Non-monotonic on "A" event, then Qualify o then "C" event, and Trigger o out, Interval, Runt, Slew Rate	en that condition is not me n "B" event, and Trigger o on "D" event e, or Pattern (analog), f events
Measurement Trigger Cascade (Sequence) Triggerin Capability Types Holdoff Reset Optional High-speed Serial P	Trigger on intermittent faults Trigger on measurement value Arm on "A" event, then Trig "C" event. Or Arm on "A" event. Or Arm on "A" event. Or Arm on "A" event. Edge, Government Trigger Holdoff between A and B, B arotocol Triggering (WR6Zi-	lues, Edge, Serial Pattern, B gger on "B" event. Or Arm of event, then Qualify on "B" t Ellitch, Width, Window, Dropo B and C, C or D, or any is sell and C, C and D, or any comb	us Pattern, Non-monotonic on "A" event, then Qualify o then "C" event, and Trigger o out, Interval, Runt, Slew Rate ectable by time or number o pination is selectable in time	en that condition is not me n "B" event, and Trigger o on "D" event e, or Pattern (analog), f events
Measurement Trigger Cascade (Sequence) Triggeric Capability Types Holdoff Reset Dptional High-speed Serial P Data Rates	Trigger on intermittent faults Trigger on measurement value Arm on "A" event, then Trig "C" event. Or Arm on "A" event: Edge, Governent Trigger Holdoff between A and B, E Reset between A and B, B average of the service of the se	lues, Edge, Serial Pattern, B gger on "B" event. Or Arm of event, then Qualify on "B" t Ellitch, Width, Window, Dropo B and C, C or D, or any is sell and C, C and D, or any comb	us Pattern, Non-monotonic on "A" event, then Qualify o then "C" event, and Trigger o out, Interval, Runt, Slew Rate ectable by time or number o pination is selectable in time	en that condition is not me n "B" event, and Trigger o on "D" event e, or Pattern (analog), f events
Measurement Trigger Cascade (Sequence) Triggerin Capability Types Holdoff Reset Dptional High-speed Serial P Data Rates Pattern Length	Trigger on intermittent faults Trigger on measurement value Arm on "A" event, then Trig "C" event. Or Arm on "A" e A, B, C, or D event: Edge, G Measurement Trigger Holdoff between A and B, B Reset between A and B, B rotocol Triggering (WR6Zi- N/A N/A	lues, Edge, Serial Pattern, B gger on "B" event. Or Arm of event, then Qualify on "B" t Ellitch, Width, Window, Dropo B and C, C or D, or any is sell and C, C and D, or any comb	us Pattern, Non-monotonic on "A" event, then Qualify o then "C" event, and Trigger o out, Interval, Runt, Slew Rate ectable by time or number o oination is selectable in time 150 Mb/s-3 Gb/s 80-bits, NRZ or 8b/10b	en that condition is not me n "B" event, and Trigger o on "D" event e, or Pattern (analog), f events
Measurement Trigger Cascade (Sequence) Triggerin Capability Types Holdoff Reset Optional High-speed Serial P Data Rates Pattern Length Clock and Data Outputs	Trigger on intermittent faults Trigger on measurement value Arm on "A" event, then Trig "C" event. Or Arm on "A" event: Edge, Governent Trigger Holdoff between A and B, E Reset between A and B, B average of the service of the se	lues, Edge, Serial Pattern, Bugger on "B" event. Or Arm of event, then Qualify on "B" tiltch, Width, Window, Dropostand C, C or D, or any is selegand C, C and D, or any combatters.	us Pattern, Non-monotonic on "A" event, then Qualify o then "C" event, and Trigger o out, Interval, Runt, Slew Rate ectable by time or number o oination is selectable in time 150 Mb/s-3 Gb/s 80-bits, NRZ or 8b/10b Not available Unit Interval RMS for PRBS of	en that condition is not me n "B" event, and Trigger o on "D" event e, or Pattern (analog), f events or number of events
Measurement Trigger Cascade (Sequence) Triggeric Capability Types Holdoff Reset Optional High-speed Serial P Data Rates Pattern Length Clock and Data Outputs Clock Recovery Jitter	Trigger on intermittent faults Trigger on measurement value Arm on "A" event, then Trig "C" event. Or Arm on "A" e A, B, C, or D event: Edge, G Measurement Trigger Holdoff between A and B, B Reset between A and B, B a rotocol Triggering (WR6Zi- N/A N/A N/A N/A N/A N/A	lues, Edge, Serial Pattern, Buger on "B" event. Or Arm of event, then Qualify on "B" tiltch, Width, Window, Drope and C, C or D, or any is selegand C, C and D, or any combe and C, C and D, o	us Pattern, Non-monotonic on "A" event, then Qualify o then "C" event, and Trigger o out, Interval, Runt, Slew Rate ectable by time or number o oination is selectable in time 150 Mb/s-3 Gb/s 80-bits, NRZ or 8b/10b Not available	en that condition is not me n "B" event, and Trigger o on "D" event e, or Pattern (analog), f events or number of events
Measurement Trigger Cascade (Sequence) Triggeric Capability Types Holdoff Reset Optional High-speed Serial P Data Rates Pattern Length Clock and Data Outputs Clock Recovery Jitter Hardware Clock Recovery Loop B\	Trigger on intermittent faults Trigger on measurement value Arm on "A" event, then Trig "C" event. Or Arm on "A" e A, B, C, or D event: Edge, G Measurement Trigger Holdoff between A and B, B Reset between A and B, B a rotocol Triggering (WR6Zi- N/A N/A N/A N/A N/A N/A	lues, Edge, Serial Pattern, Buger on "B" event. Or Arm of event, then Qualify on "B" tiltch, Width, Window, Drope and C, C or D, or any is selegand C, C and D, or any combe and C, C and D, o	us Pattern, Non-monotonic on "A" event, then Qualify o then "C" event, and Trigger o out, Interval, Runt, Slew Rate ectable by time or number o oination is selectable in time 150 Mb/s-3 Gb/s 80-bits, NRZ or 8b/10b Not available Unit Interval RMS for PRBS o 50% transition density Loop BW = Fbaud/5500, 100	en that condition is not me n "B" event, and Trigger o on "D" event e, or Pattern (analog), f events or number of events
Measurement Trigger Cascade (Sequence) Triggerin Capability Types Holdoff Reset Optional High-speed Serial P Data Rates Pattern Length Clock and Data Outputs Clock Recovery Jitter Hardware Clock Recovery Loop BN Color Waveform Display	Trigger on intermittent faults Trigger on measurement value Arm on "A" event, then Trig "C" event. Or Arm on "A" e A, B, C, or D event: Edge, G Measurement Trigger Holdoff between A and B, B Reset between A and B, B a rotocol Triggering (WR6Zi- N/A	lues, Edge, Serial Pattern, Bugger on "B" event. Or Arm of event, then Qualify on "B" tillitch, Width, Window, Drope and C, C or D, or any is self and C, C and D, or any combined and C, C an	us Pattern, Non-monotonic on "A" event, then Qualify o then "C" event, and Trigger o out, Interval, Runt, Slew Rate ectable by time or number o oination is selectable in time 150 Mb/s-3 Gb/s 80-bits, NRZ or 8b/10b Not available Unit Interval RMS for PRBS o 50% transition density Loop BW = Fbaud/5500, 100	en that condition is not me n "B" event, and Trigger o on "D" event e, or Pattern (analog), f events or number of events data patterns with
Measurement Trigger Cascade (Sequence) Triggerin Capability	Trigger on intermittent faults Trigger on measurement value Arm on "A" event, then Trig "C" event. Or Arm on "A" e A, B, C, or D event: Edge, G Measurement Trigger Holdoff between A and B, B Reset between A and B, B a rotocol Triggering (WR6Zi- N/A	lues, Edge, Serial Pattern, Bugger on "B" event. Or Arm of event, then Qualify on "B" tillitch, Width, Window, Drope and C, C or D, or any is self and C, C and D, or any combined and C, C an	us Pattern, Non-monotonic on "A" event, then Qualify o then "C" event, and Trigger o out, Interval, Runt, Slew Rate ectable by time or number o oination is selectable in time 150 Mb/s–3 Gb/s 80-bits, NRZ or 8b/10b Not available Unit Interval RMS for PRBS o 50% transition density Loop BW = Fbaud/5500, 100 to 2.488 Gb/s (typical)	en that condition is not me n "B" event, and Trigger o on "D" event e, or Pattern (analog), f events or number of events data patterns with
Measurement Trigger Cascade (Sequence) Triggerin Capability Types Holdoff Reset Optional High-speed Serial P Data Rates Pattern Length Clock and Data Outputs Clock Recovery Jitter Hardware Clock Recovery Loop BN Color Waveform Display Type	Trigger on intermittent faults Trigger on measurement value Arm on "A" event, then Trig "C" event. Or Arm on "A" e A, B, C, or D event: Edge, G Measurement Trigger Holdoff between A and B, B Reset between A and B, B rotocol Triggering (WR6Zi- N/A N/A N/A N/A N/A N/A N/A N/	lues, Edge, Serial Pattern, Bugger on "B" event. Or Arm of event, then Qualify on "B" tillitch, Width, Window, Dropoland C, C or D, or any is selegand C, C and D, or any combined and C, C an	us Pattern, Non-monotonic on "A" event, then Qualify o then "C" event, and Trigger o out, Interval, Runt, Slew Rate ectable by time or number o oination is selectable in time 150 Mb/s–3 Gb/s 80-bits, NRZ or 8b/10b Not available Unit Interval RMS for PRBS o 50% transition density Loop BW = Fbaud/5500, 100 to 2.488 Gb/s (typical)	en that condition is not me n "B" event, and Trigger o on "D" event e, or Pattern (analog), f events or number of events data patterns with) Mb/s

	WaveRunner HRO 64 Zi HRO 66 Zi	WaveRunner 604 Zi 606 Zi	WaveRunner 610 Zi 620 Zi	WaveRunner 625 Zi 640 Zi
Processor/CPU				
Type	Intel® E5300 Pentium Dual	Core 2.6 GHz or greater		
Processor Memory	4 GB standard	2 (GB standard, up to 4 GB option	onal
Operating System	Microsoft Windows® 7 Prof	essional for Embedded Sys	tems, 64-bit	
Real Time Clock	Date and time displayed with	n waveform in hardcopy files	s. SNTP support to synchroniz	re to precision internal clo
nterface				
Remote Control	Via Windows Automation, o		nand Set	
Network Communication Standard	VXI-11 or VICP, LXI Class C	(v1.2) Compliant		
GPIB Port (Optional)	Supports IEEE—488.2 (Exte	rnal)		
Ethernet Port	Supports 10/100/1000Base-	T Ethernet interface (RJ45 p	port)	
USB	Minimum 4 total (Including 2	2 front panel) USB 2.0 ports	support Windows compatib	le devices
USB Device Port	1 USBTMC Port			
External Monitor Port			omer-supplied external monit VXGA resolution on second r	
Peripheral Bus	LeCroy LBUS standard			
Power Requirements				
Voltage	100–240 VAC ±10% at 45–6 Automatic AC Voltage Selec			
Power Consumption (Nominal)	325 W / 325 VA	rion, motunation outogory.	400 W / 400 VA	
Max Power Consumption	425 W / 425 VA (with all PC peripherals, active probes connected to 4 channels, and MSO active)		vith all PC peripherals, active o 4 channels, and MSO activ	•
Environmental				
Temperature (Operating)	+5 °C to +40 °C			
Temperature (Non-Operating)	–20 °C to +60 °C			
Humidity (Operating)	5% to 80% relative humidity Upper limit derates to 50%			
Humidity (Non-Operating)	5% to 95% relative humidity			
Altitude (Operating)	Up to 10,000 ft. (3,048 m) a	t or below +25 °C		
Random Vibration (Operating)	0.31 g _{rms} 5 Hz to 500 Hz, 15		rthogonal axes	
Random Vibration (Non-Operating)	2.4 g _{rms} 5 Hz to 500 Hz, 15			
Functional Shock			tive) in each of three orthogona	l axes, 18 shocks total
Physical Dimensions				
Dimensions (HWD)	11.6929" H x 16.4567" W x 8	8.937" D (297 x 418 x 227 m	nm)	
Weight	25.4 lbs. (11.52 kg)			
Shipping Weight	36 lbs. (16.36 kg)		39 lbs. (17.69 kg)	
Certifications				
	CE Compliant, UL and cUL I CSA C22.2 No. 61010-1-04	isted; Conforms to EN 6132	26-1, EN 61010-1, UL 61010-	1 2nd edition, and
Warranty and Service				
	3-year warranty; calibration upgrades, and calibration se		tional service programs inclu	de extended warranty,

Standard

Math Tools

Display up to 8 math function traces (F1–F8). The easy-to-use graphical interface simplifies setup of up to two operations on each function trace, and function traces can be chained together to perform math-on-math.

absolute value
average (summed)
average (continuous)
correlation
(two waveforms)
cubic interpolation
derivative
deskew (resample)
difference (–)
enhanced resolution
(to 11 bits vertical)
envelope

exp (base e) log (base 10) exp (base 10) product (x) fft (power spectrum, reciprocal power average, rescale (with units) magnitude, phase, roof up to 128 Mpts) (sinx)/x floor sparse integral square interpolate (cubic, square root quadratic, sinx/x) sum (+) invert (negate) zoom (identity) log (base e)

Measure Tools

Display any 8 parameters together with statistics, including their average, high, low, and standard deviations. Histicons provide a fast, dynamic view of parameters and wave shape characteristics. Parameter Math allows addition, subtraction, multiplication, or division of two different parameters.

amplitude level @ x rms area maximum std. deviation base mean top cycles median width minimum median data delay narrow band phase phase Δ delay narrow band power time @ minimum (min.) duty cycle number of points time @ maximum (max.) + overshoot Δ time @ level duration falltime (90-10%, Δ time @ level from - overshoot 80-20%, @ level) trigger peak-to-peak frequency x @ max. period first x@min. risetime (10-90%. last 20-80%, @ level)

Standard (cont'd)

Pass/Fail Testing

Simultaneously test multiple parameters against selectable parameter limits or pre-defined masks. Pass or fail conditions can initiate actions including document to local or networked files, e-mail the image of the failure, save waveforms, send a pulse out at the front panel auxiliary BNC output, or (with the GPIB option) send a GPIB SRQ.

Jitter and Timing Analysis

This package provides jitter timing and analysis using time, frequency, and statistical views for common timing parameters, and also includes other useful tools. Includes:

- "Track" graphs of all parameters, no limitation of number
- Cycle-Cycle Jitter
 Period @ level
 Setup
 N-Cycle
 Half Period
 Hold
 N-Cycle with
 Width @ level
 Skew
- start selection Time Interval Duty Cycle @ level Frequency @ level Error @ level Duty Cycle Error
- Edge @ Iv parameter (counts edges)
- Histograms expanded with 19 histogram parameters and up to 2 billion events
- Trend (datalog) of up to 1 million events
- Track graphs of all parameters
- Persistence histogram, persistence trace (mean, range, sigma)

Software Options

SDA II Serial Data Analysis Option (WR6Zi-SDAII)

Total Jitter

A complete toolset is provided to measure total jitter. Eye Diagrams with millions of UI are quickly calculated from up to 128 Mpts records, and advanced tools may be used on the Eye Diagram to aid analysis. Complete TIE and Total Jitter (Tj) parameters and analysis functions are provided.

- Time Interval Error (TIE) Measurement Parameter, Histogram, Spectrum and Jitter Track
- Total Jitter (Tj) Measurement Parameter, Histogram, Spectrum
- Eye Diagram Display (sliced)
- Eye Diagram IsoBER (lines of constant Bit Error Rate)
- Eye Diagram Mask Violation Locator
- Eye Diagram Measurement Parameters

- Mask hits - Eye Height - Eve Width - One Level - Mask out - Eye Crossing - Zero Level - Bit Error Rate - Avg. Power - Slice Width - Eye Amplitude - Extinction Ratio (setting)

- Q-Fit Tail Representation
- Bathtub Curve
- Cumulative Density Function (CDF)
- PLL Track

Jitter Decompostion Models

Two jitter decomposition methods are provided and simultaneously calculated to provide maximum measurement confidence. Q-Scale, CDF, Bathtub Curve, and all jitter decomposition measurement parameters can be displayed using either method.

- Spectral Method
- NQ-Scale Method

Random Jitter (Rj) and Non-Data Dependent Jitter (Rj+BUj)

- Random Jitter (Rj) Measurement Parameter
- Rj+BUj Histogram
- Rj+BUj Spectrum
- Rj+BUj Track

Deterministic Jitter (Dj)

Deterministic Jitter (Dj) Measurement Parameter

Data Dependent Jitter (DDj)

- Data Dependent Jitter (DDj) Measurement Parameter
- DDi Histogram
- DDj Plot (by Pattern or N-bit Sequence)

Software Options (cont'd)

Cable De-embedding Option (WR6Zi-CBL-DE-EMBED)

Removes cable effects from your measurements. Simply enter the S-parameters or attenuation data of the cable(s) then all of the functionality of the WR6Zi can be utilized with cable effects de-embedded.

8b/10b Decode and 80-bit High Speed Serial Trigger Option (WR6Zi-80B-8B10B TD)*

Intuitive, color-coded serial trigger decode with powerful search capability enables captured waveforms to be searched for user-defined sequences of symbols. Multi-lane analysis decodes up to four simultaneously captured lanes. Includes 150 Mb/s to 3.125 Gb/s High-speed 80-bit Serial Pattern Trigger Option

8b/10b Decode Option (WR6Zi-HRO-80B-8B10B D)

Intuitive, color-coded serial decode with powerful search capability enables captured waveforms to be searched for user-defined sequences of symbols. Multi-lane analysis decodes up to four simultaneously captured lanes.

Serial Data Mask Option (WR6Zi-SDM)

Create eye diagrams using a comprehensive list of standard eye pattern masks, or create a user-defined mask. Mask violations are clearly marked on the display for easy analysis.

Electrical Telecom Pulse Mask Test Option (WR6Zi-ET-PMT)

Performs automated compliance mask tests on a wide range of electrical telecom standards.

Spectrum Analyzer Mode Option (WR6Zi-SPECTRUM)

This package provides a new capability to navigate waveforms in the frequency domain using spectrum analyzer type controls.

FFT capability added to include:

- Power averaging
- Power density
- · Real and imaginary components
- Frequency domain parameters
- FFT on up to 128 Mpts

Disk Drive Measurements Option (WR6Zi-DDM2)

This package provides disk drive parameter measurements and related mathematical functions for performing disk drive WaveShape Analysis.

- Disk Drive Parameters are as follows:
- amplitude assymetry
- local base
- local baseline separation
- local maximum
- local minimum
- local number
- local peak-peak
- local time between events
- local time between peaks
- local time between troughs

- local time at minimum
- local time at maximum
- local time peak-trough
- local time over threshold
 - local time trough-peak
 - local time under threshold
 - narrow band phase - narrow band power
- track average amplitude +

- overwrite

- resolution

- track average

- track average

amplitude -

amplitude

- pulse width 50

- pulse width 50 -

- pulse width 50 +

- auto-correlation s/n
- non-linear transition shift

^{*} Not available on WaveRunner HRO 6Zi models.

Product Description	Product Code	Product Description	Product Code
WaveRunner 6 Zi Series Oscillosco	pes	Memory Options	
400 MHz, 2 GS/s, 4 Ch, 64 Mpts/Ch 12-bit DSO with	WaveRunner HRO 64Zi	64 Mpts/Ch Standard Memory. Includes 4 GB of RAM	WR6Zi-HRO-STD
12.1" WXGA Color Display 600 MHz, 2 GS/s, 4 Ch,	WaveRunner HRO 66Zi	128 Mpts/Ch Memory. Includes 4 GB of RAM.	WR6Zi-HRO-L-128
64 Mpts/Ch 12-bit DSO with 12.1" WXGA Color Display		256 Mpts/Ch Memory. Includes 4 GB of RAM	WR6Zi-HRO-XL-256
400 MHz, 10 GS/s, 4 Ch, 16 Mpts/Ch DSO with 12.1" WXGA Color Display. 50 Ω and 1 M Ω Input 20 GS/s and 32 Mpts/Ch in Interleaved Mode	WaveRunner 604Zi	16 Mpts/Ch (32 Mpts/Ch Interleaved) Standard Memory. Includes 2 GB of RAM	WR604Zi-STD
600 MHz, 10 GS/s, 4 Ch, 16 Mpts/Ch DSO with 12.1" WXGA Color Display. 50 Ω and 1 M Ω Input 20 GS/s and	WaveRunner 606Zi	16 Mpts/Ch (32 Mpts/Ch Interleaved) Standard Memory. Includes 2 GB of RAM	WR606Zi-STD
32 Mpts/Ch in Interleaved Mode 1 GHz, 10 GS/s, 4 Ch, 16 Mpts/Ch	WaveRunner 610Zi	16 Mpts/Ch (32 Mpts/Ch Interleaved) Standard Memory. Includes 2 GB of RAM	WR610Zi-STD
DSO with 12.1" WXGA Color Display. 50 Ω and 1 M Ω Input 20 GS/s and 32 Mpts/Ch in Interleaved Mode		16 Mpts/Ch (32 Mpts/Ch Interleaved) Standard Memory. Includes 2 GB of RAM	WR620Zi-STD
2 GHz, 10 GS/s, 4 Ch, 16 Mpts/Ch DSO with 12.1" WXGA Color Display. 50 Ω and 1 M Ω Input 20 GS/s and 32 Mpts/Ch in Interleaved Mode	WaveRunner 620Zi	16 Mpts/Ch (32 Mpts/Ch Interleaved) Standard Memory. Includes 2 GB of RAM	WR625Zi-STD
2.5 GHz, 20 GS/s, 4 Ch, 16 Mpts/Ch DSO with 12.1" WXGA Color Display. 50 Ω and 1 M Ω Input 40 GS/s and	WaveRunner 625Zi	16 Mpts/Ch (32 Mpts/Ch Interleaved) Standard Memory. Includes 2 GB of RAM	WR640Zi-STD
32 Mpts/Ch in Interleaved Mode 4 GHz, 20 GS/s, 4 Ch, 16 Mpts/Ch DSO with 12.1" WXGA Color Display.	WaveRunner 640Zi	32 Mpts/Ch (64 Mpts/Ch Interleaved) Standard Memory. Includes 4 GB of RAM	WR604Zi-S-32
50 Ω and 1 M Ω Input 40 GS/s and 32 Mpts/Ch in Interleaved Mode		32 Mpts/Ch (64 Mpts/Ch Interleaved) Standard Memory. Includes 4 GB of RAM	WR606Zi-S-32
Included with Standard Configurat	tion	32 Mpts/Ch (64 Mpts/Ch Interleaved)	WR610Zi-S-32
÷10, 500 MHz Passive Probe (Qty. 4) Optical 3-button Wheel Mouse, USB 2.0		Standard Memory. Includes 4 GB of RAM	
Printed Quick Reference Guide Printed Getting Started Manual Product Manual in PDF Format on Oscillo	scope Desktop	32 Mpts/Ch (64 Mpts/Ch Interleaved) Standard Memory. Includes 4 GB of RAM	WR620Zi-S-32
Anti-virus Software (Trial Version) Microsoft Windows® 7 for Embedded Sy Commercial NIST Traceable Calibration w		32 Mpts/Ch (64 Mpts/Ch Interleaved) Standard Memory. Includes 4 GB of RAM	WR625Zi-S-32
Power Cable for the Destination Country 3-year Warranty		32 Mpts/Ch (64 Mpts/Ch Interleaved) Standard Memory. Includes 4 GB of RAM	WR640Zi-S-32
Oscilloscope Synchronization 8 Channel Simultaneous Acquisition- Capture and Transfer Waveforms	WR6ZI-8CH-SYNCH	64 Mpts/Ch (128 Mpts/Ch Interleaved) Standard Memory. Includes 4 GB of RAM	WR604Zi-M-64
Between Two WR 6Zi or HRO 6Zi Oscilloscopes		64 Mpts/Ch (128 Mpts/Ch Interleaved) Standard Memory. Includes 4 GB of RAM	WR606Zi-M-64
		64 Mpts/Ch (128 Mpts/Ch Interleaved) Standard Memory. Includes 4 GB of RAM	WR610Zi-M-64
		64 Mpts/Ch (128 Mpts/Ch Interleaved) Standard Memory. Includes 4 GB of RAM	WR620Zi-M-64

Drive Analyzers

Product Description	Product Code	Product Description	Product Code
Memory Options (cont'd)		Serial Trigger and Decode (cont'o	d)
64 Mpts/Ch (128 Mpts/Ch Interleaved) Standard Memory. Includes 4 GB	WR625Zi-M-64	ARINC 429 Bus Symbolic Decode Option	WR6Zi-ARINCbus DSymbolic
of RAM 64 Mpts/Ch (128 Mpts/Ch Interleaved)	WR640Zi-M-64	UART and RS-232 Trigger and Decode Option	WR6Zi-UART-RS232bus TD
Standard Memory. Includes 4 GB of RAM		CANbus TD Trigger and Decode Option	WR6Zi-CANbus TD
Memory and Sample Rate Options		CANbus TDM Trigger, Decode and Measure/Graph Option	WR6Zi-CANbus TDM
20 GS/s (40 GS/s Interleaved) Sampling Rate Option	WR610Zi-STD-4x20GS	FlexRay Trigger and Decode Option	WR6Zi-FlexRaybus TD
32 Mpts/Ch (64 Mpts/Ch Interleaved) Standard Memory. Includes 4 GB of	WR610Zi-S-32+4x20GS	FlexRay Trigger, Decode, and Physical Layer Test Option	WR6Zi-FlexRaybus TDP
RAM. 20 GS/s (40 GS/s Interleaved)		LIN Trigger and Decode Option	WR6Zi-LINbus TD
Sampling Rate Option 64 Mpts/Ch (128 Mpts/Ch Interleaved) Standard Memory. Includes 4 GB of	WR610Zi-M-64+4x20GS	Vehicle Bus Analyzer Package - Includes CANBus TDM, FlexRay TDP, LINBus TD, and ProtoBus MAG	WR6Zi-VBA
RAM. 20 GS/s (40 GS/s Interleaved) Sampling Rate Option		8b/10b Trigger and Decode Option	WR6Zi-80B-8B10B TD
20 GS/s (40 GS/s Interleaved) Sampling Rate Option	WR620Zi-STD-4x20GS	MIL-STD-1553 Trigger and Decode Option	WR6Zi-1553 TD
32 Mpts/Ch (64 Mpts/Ch Interleaved) Standard Memory. Includes 4 GB of	WR620Zi-S-32+4x20GS	Audiobus Trigger and Decode for I ² S, Option LJ, RJ, and TDM	WR6Zi-Audiobus TD
RAM. 20 GS/s (40 GS/s Interleaved) Sampling Rate Option		Audiobus Trigger, Decode, and Graph Option for I ² S, LJ, RJ, and TDM	WR6Zi-Audiobus TDG
64 Mpts/Ch (128 Mpts/Ch Interleaved)	WR620Zi-M-64+4x20GS	USB 1.x/2.0 Trigger/Decode Option	WR6Zi-USB2bus TD
Standard Memory. Includes 4 GB of RAM. 20 GS/s (40 GS/s Interleaved)		USB2-HSIC Decode Option	WR6Zi-USB2-HSICbus D
Sampling Rate Option		PCI Express Gen1 Decode Option	WR6Zi-PClebus D
Computer Upgrade		SATA Trigger Decode Annotation Option Supports SATA Gen1, 2, and 3	WR6Zi-SATAbus TD
Upgrade From 2 GB RAM to 4 GB RAM	WR6Zi-UPG-4GBRAM	SAS Decode Annotation Option PCI Express Gen1 Trigger and	WR6Zi-SASbus D
Removeable Hard Drive Option	WR6Zi-160GB-RHD	Decode Annotation Option	\A\D07' F0\ D
Removeable 500 GB Hard Drive Option	WR6Zi-500GB-RHD	Fibre Channel Decode Annotation Option	WR6Zi-FCbus D
Additional 160 GB Hard Drive for Use With RHD Option. Includes	WR6Zi-160GB-RHD-02	DigRF 3G Decode Option	WR6Zi-DigRF3Gbus D
Windows 7 Pro for Embedded		DigRF v4 Decode Option	WR6Zi-DigRFv4bus D
Systems OS, LeCroy Oscilloscope Software and Critical Scope		MIPI D-PHY Decode Option	WR6Zi-DPHYbus D
Operational File Duplicates Additional 500 GB Hard Drive	WR6Zi-500GB-RHD-02	MIPI D-PHY Decode and Physical Layer Test Option	WR6Zi-DPHYbus DP
for Use With RHD Option. Includes		MIPI M-PHY Decode Option	WR6Zi-MPHYbus D
Windows 7 Pro for Embedded Systems OS, LeCroy Oscilloscope Software and Critical Scope		MIPI M-PHY Decode and Physical Layer Test Option	WR6Zi-MPHYbus DP
Operational File Duplicates		PROTObus MAG Serial Debug Toolkit	WR6Zi-PROTObus MAG
Upgrade From Standard Size Hard Drive to 500 GB Hard Drive	WR6Zi-500GB-HD	Decode Annotation and Protocol Analyzer Synchronization Software Option	WR6Zi-ProtoSync
Serial Trigger and Decode		I ² C, SPI and UART Trigger and	WR6Zi-EMB
Cable De-Embedding Option	WR6Zi-CBL-DE-EMBED	Decode Option MS-500-36 with I ² C, SPI and UART	WR6Zi-MSO-EMB
Eye Doctor (Virtual Probe and Equalizer Emulation Bundle), Serial Data Analyzers, and Disk	WR6Zi-EYEDRII	Trigger and Decode Option	

Product Description	Product Code	Product Description	Product Code
Serial Data Compliance		Data Storage Software	
QualiPHY Enabled Ethernet 10/100/1000BT Software Option	QPHY-ENET*	Disk Drive Measurements Software Option	WR6Zi-DDM2
QualiPHY Enabled USB 2.0	QPHY-USB ‡	Disk Drive Analyzer Software Option	WR6Zi-DDA
Software Option QualiPHY Enabled SATA Software Option	QPHY-SATA-TSG-RSG	Advanced Optical Recording Measurement Option	WR6Zi-AORM
QualiPHY Enabled MIPI D-PHY	QPHY-MIPI-DPHY	Power Analysis Software	
Software Option		PowerMeasure Analysis	WR6Zi-PMA2
QualiPHY Enabled DDR2 Software Option	QPHY-DDR2	Software Option	
QualiPHY Enabled LPDDR2	QPHY-LPDDR2	Jitter Analysis Software	WR6Zi-JITKIT
Software Option	00111/0000	Clock Jitter Analysis with Four Views Software Option	VVNOZI-JITKIT
QualiPHY Enabled DDR3 Software Option	QPHY-DDR3	Other Software Options	
QualiPHY Enabled MOST150o	QPHY-MOST150o	Advanced Customization Option	WR6Zi-XDEV
Software Option		Spectrum Analyzer and	WR6Zi-SPECTRUM
QualiPHY Enabled MOST50e Software Option	QPHY-MOST50e	Advanced FFT Option	VVIIOZI GI ZGTITOWI
QualiPHY Enabled BroadR-Reach Software Option	QPHY-BroadR-Reach	EMC Pulse Parameter Software Option	WR6Zi-EMC
10/100/1000Base-T Ethernet Test Fixture	TF-ENET-B**	Electrical Telecom Mask Test Software Option	WR6Zi-ET-PMT
Telecom Adapter Kit 100 Ω Bal., 120 Ω Bal., 75 Ω Unbal.	TF-ET	Digital Filtering Software	W(D07; DED0
SATA 1.5 Gb/s, 3.0 Gb/s and 6.0 Gb/s Compliance Test Fixture	TF-SATA-C	Digital Filter Software Option WR6Zi-DFI Remote Control/Network Options	
USB 2.0 Compliance Test Fixture	TF-USB-B	External USB2 to GPIB Adaptor	USB2-GPIB
* TF-ENET-B required.		General Accessories	
		Oscilloscope Cart with	OC1024
		Additional Shelf and Drawer	
Serial Data Mask Software Option	WR6Zi-SDM	Oscilloscope Cart	OC1021
SDA II Serial Data Analysis Option	WR6ZI-SDAII	Accessory Pouch	WR6Zi-POUCH
		Rackmount, 8U Adaptor Kit	WR6ZI-RACK
Mixed Signal Solutions		Keyboard, USB	KYBD-1
250 MHz, 1 GS/s, 18 Ch, 10 Mpts/Ch Mixed Signal Oscilloscope Option	MS-250	MIL Calibration Certification	WR6Zi-CCMIL
500 MHz, 2 GS/s, 18 Ch, 50 Mpts/Ch	MS-500	Soft Carrying Case	WR6Zi-SOFTCASE
Mixed Signal Oscilloscope Option	1913-5000	Protective Hard Cover	WR6Zi-COVER
250 MHz, 1 GS/s, 36 Ch, 25 Mpts/Ch (500 MHz, 18 Ch, 2 GS/s, 50 Mpts/Ch Interleaved) Mixed Signal Oscilloscope Option	MS-500-36	External Adaptor for Reference In and Out (To be applied at the Lbus Connector)	WR6Zi-ExtRef-IN/OUT

Product Description	Product Code
Probes	
÷10, 500 MHz 10 MΩ Passive Probe	PP009
\div 10, 500 MHz 10 M Ω Passive Probe	PP008
200 MHz, 3.5 pF, 1 M Ω Active Differential Probe	ZD200
500 MHz, 1.0 pF, 1 M Ω Active Differential Probe	ZD500
1 GHz, 1.0 pF, 1 M Ω Active Differential Probe	ZD1000
1.5 GHz, 1.0 pF, 1 M Ω Active Differential Probe	ZD1500
1 GHz, 0.9 pF, 1 M Ω High Impedance Active Probe	ZS1000
Set of 4 ZS1000, 1 GHz, 0.9 pF, 1 MΩ High Impedance Active Probe	ZS1000-QUADPAK
1.5 GHz, 0.9 pF, 1 MΩ High Impedance Active Probe	ZS1500
Set of 4 ZS1500, 1.5 GHz, 0.9 pF, 1 MΩ High Impedance Active Probe	ZS1500-QUADPAK
2.5 GHz, 0.9 pF, 1 MΩ High Impedance Active Probe	ZS2500
Set of 4 ZS2500, 2.5 GHz, 0.9 pF, 1 MΩ High Impedance Active Probe	ZS2500-QUADPAK
WaveLink 6 GHz Differential Amplifier Module with Adjustable Tip	D600A-AT
WaveLink 3 GHz Differential Amplifier Module with Adjustable Tip	D300A-AT
WaveLink 5 GHz Differential Amplifier Module with Positioner Tip	D500PT
Optical-to-Electrical Converter, 500-870 nm ProBus BNC Connector	OE425
Optical-to-Electrical Converter, 950-1630 nm ProBus BNC Connector	OE455
1,400 V, 20 MHz High-Voltage Differential Probe	ADP300
1,400 V, 100 MHz High-Voltage Differential Probe	ADP305
10:1/100:1 200/300 MHz 50 MΩ High-Voltage Probe 600 V/1.2 kV Max. Volt. DC	PPE1.2KV
100:1 400 MHz 50 M Ω 2 kV High-Voltage Probe	PPE2KV
100:1 400 MHz 50 MΩ 4 kV High-Voltage Probe	PPE4KV
1000:1 400 MHz 50 MΩ 5 kV High-Voltage Probe	PPE5KV

Product Description	Product Code
Probes (cont'd)	
1000:1 400 MHz 5 M Ω / 50 M Ω 6 kV High-Voltage Probe	PPE6KV
1000:1 100 MHz 100MΩ High-Voltage Probe 20 kV Max. Volt. DC + 40 kV Peak AC	PPE20KV
30 A; 50 MHz Current Probe – AC/DC; 30 Arms; 50 Apeak Pulse	AP015
30 A; 50 MHz Current Probe – AC/DC; 30 Arms; 50 Apeak Pulse	CP030
30 A; 100 MHz Current Probe – AC/DC; 30 Arms; 50 Apeak Pulse	CP031
150 A; 10 MHz Current Probe – AC/DC; 150 Arms; 500 Apeak Pulse	CP150
500 A; 2 MHz Current Probe – AC/DC; 500 Arms; 700 Apeak Pulse	CP500
700 V, 15 MHz High-Voltage Differential Probe (÷10, ÷100)	AP031
1 Ch, 100 MHz Differential Amplifier with Precision Voltage Source	DA1855A
DA1855A with Rackmount	DA1855A-RM
2 Ch, 100 MHz Differential Amplifier with Precision Voltage Source	DA1855A-PR2
DA1855A with Rackmount (must be ordered at time of purchase, no retrofit)	DA1855A-PR2-RM
WaveLink ProBus Platform/Cable Assembly (4 GHz)	WL-PBus
WaveLink 4 GHz 2.5 Vp-p Differential Amplifier Small Tip Module	D410*
WaveLink 4 GHz 5 Vp-p Differential Amplifier Small Tip Module	D420*
WaveLink 4 GHz, 2.5 Vp-p Differential Positioner Tip	D410-PT
WaveLink 4 GHz, 5 Vp-p Differential Positioner Tip	D420-PT

^{*} For a complete probe, order a PBus Platform/Cable Assembly with the Probe Tip Module.



1-800-5-LeCroy www.lecroy.com Local sales offices are located throughout the world. Visit our website to find the most convenient location.

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